Angle-robust two-qubit gates in a linear ion crystal

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In trapped-ion quantum computers, two-qubit entangling gates are generated by applying spin-dependent force which uses phonons to mediate interaction between the internal states of the ions. To maintain high-fidelity two-qubit gates under fluctuating experimental parameters, robust pulse-design methods are applied to remove the residual spin-motion entanglement in the presence of motional mode-frequency drifts. Here we propose an improved pulse-design method that also guarantees the robustness of the two-qubit rotation angle against uniform mode-frequency drifts by concatenating pulses with opposite sensitivity of the angle to mode-frequency drifts. We experimentally verify significantly improved robustness of the rotation angle against uniform mode-frequency drifts, as well as observe an improvement in gate fidelity from 97.84(10)% to 98.11(11)%, compared to a single frequency-modulated pulse.

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I. INTRODUCTION

The trapped atomic-ion system is a leading platform for quantum computation and simulation [1,2]. It has several appealing features including long coherence time [3,4], fast and efficient state preparation and measurement [5-7], and highfidelity single-qubit [7–9] and two-qubit gates [10–15]. As the most challenging component, the two-qubit gates are commonly implemented by Mølmer-Sørensen (MS) type interactions [16,17], which utilize the motional modes to mediate couplings between spins. For exactly two-ion systems, a twoqubit gate fidelity exceeding 99.9% has been demonstrated [10,11,13–15]. For longer ion chains with more complicated motional-mode spectra, several approaches including amplitude modulation (AM) [18-23], frequency modulation (FM) [12,24–26], phase modulation (PM) [27–29], and multitone driving fields [30-32] have been utilized to efficiently decouple spins from all motional modes, achieving 98.5%-99.3% fidelity with 15 ions [33] and 97.5% fidelity with 13 ions [34], 16 ions [35], and 25 ions [23].

As the circuit depth increases, the performance of the MS gate is sensitive to slow drifts of motional-mode frequencies, resulting in undesired residual spin-motion entanglement and two-qubit over-rotation errors. Previous works [22,24,29,36] have focused on minimizing both the residual spin-motion entanglement and its first-order response to unknown mode-

frequency drifts, which are usually referred to as robust gates. Meanwhile, few works have addressed the sensitivity of the two-qubit over-rotation errors, which was recently demonstrated by the repeated measurement of MS gate fidelity [12]. On the circuit level, the over-rotation error can be suppressed by local optimization [37-41]. On the gate level, one can use single-qubit composite pulses to correct two-qubit over-rotation errors [42,43], but due to the long twoqubit gate time it is not experimentally applicable. References [25,44] applied machine learning and numerical optimization techniques to reduce the over-rotation errors due to modefrequency drifts, without being able to completely remove the first-order sensitivity. Reference [22] proposed a scheme that eliminates such sensitivity to arbitrary order by applying different pulses on the two ions, but the scheme was not verified experimentally.

In this paper, we propose a method called A(ngle)-robust that achieves a similar goal by concatenating two different robust MS pulses. Inheriting the robustness of negligible residual spin-motion entanglement, the two-qubit rotation angle of an A-robust gate is first-order insensitive against uniform frequency drifts on all modes. Our scheme is experimentally verified on a two-ion platform and can, in principle, be realized in longer ion chains. The paper is organized as follows. In Sec. II, we review the general theory of the robust MS gate and discuss how its fidelity can be affected. In Sec. III, we introduce the analytic construction of A-robust pulses in two-ion chains and long ion chains and show the simulated behavior of A-robust gates in comparison with that of robust gates. In Sec. IV, we experimentally verify that the A-robust gate outperforms the robust gate against mode-frequency offsets in a two-ion chain. Finally, in Sec. V we summarize our results and discuss further directions.

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II. BACKGROUND

A. The Mølmer-Sørensen gate

The Mølmer-Sørensen (MS) gate entangles the spin states of two ions in an ion chain by applying a state-dependent force. On each target ion j_1 and j_2 , we apply driving fields with the same Rabi frequency $\Omega(t)$ and opposite detunings $\pm \delta(t)$ with respect to the carrier transition, where δ is close to resonance with the motional frequency. Under Lamb-Dicke and rotating-wave approximations, the effective Hamiltonian can be written as [16,17]

$$H_{\rm MS}(t) = \frac{\Omega(t)}{2} \sum_{j=j_1, j_2} \sum_{k} \eta_k b_j^k (\hat{a}_k e^{-i\theta_k(t)} + \hat{a}_k^{\dagger} e^{i\theta_k(t)}) \sigma_x^j, \quad (1)$$

where η_k is the Lamb-Dicke parameter of mode k, b_j^k is the normalized coupling strength of ion j to mode k, and

$$\theta_k(t) = \omega_k t - \int_0^t \delta(t') dt' \tag{2}$$

is the integrated phase of the detuning between the frequency ω_k of the kth mode and the driving field at time t. By applying Magnus expansion, at time τ , the MS Hamiltonian generates a unitary evolution of the following form [18,20]:

$$U_{\text{MS}}(\tau) = \exp\left\{ \sum_{j=j_1, j_2} \sum_{k} \left[\left(\alpha_j^k(\tau) \hat{a}_k^{\dagger} - \alpha_j^{k*}(\tau) \hat{a}_k \right) \sigma_x^j \right] + i\Theta(\tau) \sigma_x^{j_1} \sigma_x^{j_2} \right\}, \tag{3}$$

where

$$\alpha_j^k(\tau) = \frac{\eta_k b_j^k}{2} \int_0^{\tau} \Omega(t) e^{i\theta_k(t)} dt \tag{4}$$

is the displacement of mode k when spin j is in the (+1)-eigenstate of σ_x^j , and

$$\Theta(\tau) = \frac{1}{2} \sum_{k} \eta_k^2 b_{j_1}^k b_{j_2}^k \int_0^{\tau} dt \int_0^t dt'$$

$$\times \Omega(t) \Omega(t') \sin[\theta_k(t) - \theta_k(t')] \tag{5}$$

is the angle of the two-qubit rotation with respect to the axis $\sigma_x^{j_1} \sigma_x^{j_2}$.

At the end of the gate, the ion spins are completely disentangled with the motional modes, i.e., $\alpha_j^k = 0$ for all ions j and modes k. For a maximally entangled MS gate, the rotation angle Θ should be equal to $\pi/4$. In this work we refer to maximally entangled MS gates as $XX(\pi/4)$ gates. In a multi-ion chain, these conditions can be achieved by modulating either the Rabi frequency $\Omega(t)$ or the detuning $\delta(t)$ of the state-dependent driving forces in Eq. (1). The gate error $\mathcal{E} = \mathcal{E}_\alpha + \mathcal{E}_\Theta$ can be defined as follows [25]:

$$\mathcal{E}_{\alpha} = \sum_{k} \left(\left| \alpha_{j_{1}}^{k} \right|^{2} + \left| \alpha_{j_{2}}^{k} \right|^{2} \right),$$

$$\mathcal{E}_{\Theta} = \left(\Theta - \frac{\pi}{4} \right)^{2}.$$
(6)

B. Robust pulses against mode-frequency drifts

In practice, the mode frequencies ω_k might drift to $\omega_k + \epsilon_k$ for some small ϵ_k due to miscalibration and low-frequency noise (comparing to gate speed). As a result, both the residual displacement and the rotation angle experience a first-order response:

$$\alpha_j^k \to \alpha_j^k + \frac{\partial \alpha_j^k}{\partial \omega_k} \epsilon_k,$$
 (7)

$$\Theta \to \Theta + \sum_{k} \frac{\partial \Theta}{\partial \omega_k} \epsilon_k,$$
 (8)

where

$$\frac{\partial \alpha_j^k}{\partial \omega_k} = \frac{i\eta_k b_j^k}{2} \int_0^{\tau} \Omega(t) e^{i\theta_k(t)} t dt \tag{9}$$

and

$$\frac{\partial \Theta}{\partial \omega_k} = \frac{\eta_k^2 b_{j_1}^k b_{j_2}^k}{2} \int_0^{\tau} dt \int_0^t dt' \Omega(t) \Omega(t') \times (t - t') \cos[\theta_k(t) - \theta_k(t')]. \tag{10}$$

To make the MS-gate behavior insensitive to mode-frequency drifts, it is desirable to have pulses with vanishing first-order responses. Minimizing the residual entanglement and its first-order response to mode-frequency drifts is referred to as the robustness condition.

Robustness. For all j and k, we require that

$$\alpha_j^k = 0, \quad \frac{\partial \alpha_j^k}{\partial \omega_k} = 0.$$
 (11)

Previous works have been focusing on achieving the robustness condition by applying different modulation methods, including AM [22], FM [12,24], PM [27,29], and multitone driving fields [31,45]. In particular, Ref. [24] shows that, by using a time-symmetric pulse and minimizing the absolute value of the time-averaged displacement

$$\overline{\alpha_j^k} = \frac{1}{\tau} \int_0^\tau \alpha_j^k(t) dt, \tag{12}$$

the optimized pulse satisfies the robustness condition. Meanwhile, Ref. [22] points out that using AM to eliminate the first-order sensitivity of the rotation angle to drifts on each mode, i.e., $\partial\Theta/\partial\omega_k=0$ for all k, can only be achieved by applying different pulses on each ion. If the pulses on each ion are identical, it is impossible to achieve $\partial\Theta/\partial\omega_k=0$ for all k by using AM [22]. Studies on minimizing $\partial\Theta/\partial\omega_k$ for all k using other modulation schemes remain undeveloped.

III. ANGLE-ROBUST GATE BY CONCATENATING PULSES

Although minimizing $\partial\Theta/\partial\omega_k$ for each ω_k is hard to realize, we notice that, in experiments, small drifts on motional modes caused by rf or dc voltage fluctuations have the form $\epsilon_k = r_k \epsilon$, indicating the mode-frequency drifts are all proportional to some ϵ with the certain ratio r_k . Based on the observation, we propose an angle-robustness condition against drifts on all modes.

A(ngle)-robustness. In addition to the robustness condition, we also require that

$$\sum_{k} \frac{\partial \Theta}{\partial \omega_k} r_k = 0. \tag{13}$$

Specifically, for radial mode-frequency drifts in ion chains due to trap rf instability, which is a major reason of unstable radial mode frequency, uniform frequency drift ($r_k = 1$ for all k) is approximately a valid assumption and is used in the following discussions.

A. Analytic construction for two ions

We first construct MS gates in a two-ion chain which involve spin-motion coupling with a radial center-of-mass (COM) mode of frequency ω_1 and tilt mode ω_2 . The coupling strength b_j^k of two ions on two modes are $b_1^1 = b_2^1 = b_1^2 = 1/\sqrt{2}$ and $b_2^2 = -1/\sqrt{2}$, respectively. By satisfying the conditions described in Eq. (12), we can generate a robust MS-gate solution with the rotation angle $\Theta = \pi/8$ [$XX(\pi/8)$] gate] with some Rabi frequency $\Omega(t)$ and detuning $\delta(t)$, and we refer to this solution as (Ω, δ) . Consider another pulse with Rabi frequency $\tilde{\Omega}(t) = \Omega(t)$ and detuning $\tilde{\delta}(t) = \omega_1 + \omega_2 - \delta(t)$. Assuming $\eta_1 = \eta_2$, one can show that this new pulse $(\tilde{\Omega}, \tilde{\delta})$ is also a robust $XX(\pi/8)$ gate solution whose rotation angle satisfies

$$\sum_{k=1,2} \frac{\partial \tilde{\Theta}}{\partial \omega_k} = -\sum_{k=1,2} \frac{\partial \Theta}{\partial \omega_k}$$
 (14)

by using Eqs. (4), (5), (9), and (10). We then concatenate the two pulses and yield a robust $XX(\pi/4)$ gate with vanishing first-order response of the rotation angle to uniform mode-frequency drift, i.e.,

$$\Theta + \tilde{\Theta} = \frac{\pi}{4}, \quad \sum_{k=1,2} \frac{\partial(\Theta + \tilde{\Theta})}{\partial \omega_k} = 0.$$
 (15)

Therefore the concatenated pulse is A-robust.

The A-robust gate scheme can be visualized straightforwardly when concatenating two robust-FM $XX(\pi/8)$ pulses that are generated using methods explained in Refs. [12,24]. Given a robust-FM $XX(\pi/8)$ solution, we flip the pulse frequencies with respect to the average of ω_1 and ω_2 and concatenate the two pulses. Figure 1 shows an example of two-ion discrete robust and A-robust FM solutions with a gate time of 200 μ s and their rotation-angle evolution with and without uniform mode-frequency drifts.

B. Scaling up to long ion chains via amplitude modulation

In long ion chains, due to the increasing number of modes and the different values of b_j^k , searching for two robust $XX(\pi/8)$ solutions with opposite response on the rotation angle to mode-frequency drift is not as simple as that in the two-ion case. Instead of searching for two robust solutions that satisfy Eqs. (15), we aim to find two arbitrary robust gate solutions and implement a one-step AM to adjust the Rabi frequencies of the two solutions. We use notations similar to those in Sec. III A: any parameter with a tilde denotes that of the second robust gate solution. Given two robust

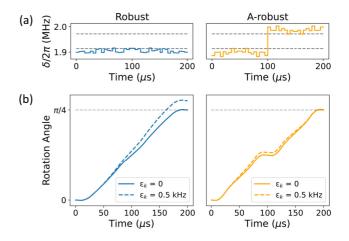


FIG. 1. An example of 200-us pulses for two-ion discrete robust (left) and A-robust FM (right) $XX(\pi/4)$ gates. (a) The gray dashed lines are the radial motional-mode frequencies. The blue (left) and orange (right) discrete solid lines are the robust and A-robust FM pulses. The two halves of the A-robust FM pulse show symmetry with respect to the average of the two mode frequencies. Note that, due to the strong coupling to the COM mode for the A-robust pulse, a low heating rate on the COM mode is beneficial. The carrier Rabi frequencies for the two solutions are 68.08 kHz for A-robust and 47.21 kHz for robust FM. Under the same optimization constraints, A-robust normally requires higher power since it optimizes for a $XX(\pi/8)$ gate with half of the full gate time. (b) Rotation angle of robust and A-robust pulses in panel (a) during the gate time. Without mode-frequency drifts (solid lines), both pulses have the rotation angle reaching $\pi/4$ at the end of the gate. When there exists a uniform drift of 0.5 kHz (dashed lines), the rotation angle of the robust pulse has an offset from $\pi/4$, while for the A-robust pulse the rotation angle is still very close to $\pi/4$.

solutions (Ω, δ) and $(\tilde{\Omega}, \tilde{\delta})$, their rotation angles Θ and $\tilde{\Theta}$, and their gradients of rotation angle to mode-frequency drift $\sum_k \partial \Theta/\partial \omega_k$ and $\sum_k \partial \tilde{\Theta}/\partial \omega_k$, respectively, we can multiply each Rabi frequency by a factor $\Omega(t) \to \beta \Omega(t)$ and a factor $\tilde{\Omega}(t) \to \tilde{\beta} \tilde{\Omega}(t)$, which changes the rotation angles to $\Theta \to \beta^2 \Theta$ and $\tilde{\Theta} \to \tilde{\beta}^2 \tilde{\Theta}$, respectively. The A-robust conditions [Eq. (13)] for a $XX(\pi/4)$ gate therefore require β and $\tilde{\beta}$ to satisfy the following equations:

$$\beta^{2}\Theta + \tilde{\beta}^{2}\tilde{\Theta} = \pi/4,$$

$$\beta^{2}\left(\sum_{k} \frac{\partial \Theta}{\partial \omega_{k}}\right) + \tilde{\beta}^{2}\left(\sum_{k} \frac{\partial \tilde{\Theta}}{\partial \omega_{k}}\right) = 0,$$
(16)

which can be easily solved. The concatenation of two gate solutions with amplitude modulation, $(\beta\Omega, \delta)$ and $(\tilde{\beta}\tilde{\Omega}, \tilde{\delta})$, performs an A-robust gate. The two-ion A-robust pulse in Sec. III A can be understood as a special case of Eq. (16) with $\Theta = \tilde{\Theta} = \pi/8$ and $\sum_k \partial \Theta/\partial \omega_k = -\sum_k \partial \tilde{\Theta}/\partial \omega_k$, which gives the solution $\beta = \tilde{\beta} = 1$. Notice that depending on the signs of Θ , $\tilde{\Theta}$, $\sum_k \partial \Theta/\partial \omega_k$, and $\sum_k \partial \tilde{\Theta}/\partial \omega_k$, Eq. (16) may return negative values for β^2 and $\tilde{\beta}^2$ due to different signs of b_j^k . This can be avoided by carefully choosing the initial-guess pulse for the pulse optimization, or if individual addressing on each ion is available, by changing the phase of one individual addressing beam by π at the beginning of the second pulse.

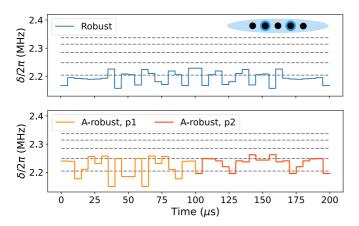


FIG. 2. An example of 200-µs pulses for five-ion discrete robust and A-robust FM $XX(\pi/4)$ gates on ions 2 and 4 in a five-ion chain. The blue (upper panel) solid lines is the robust-FM pulse, and the yellow (lower panel, 0–100 µs) and orange (lower panel, 100–200 µs) solid lines are the two halves of the A-robust FM pulse. After applying AM in Eq. (16) on the Rabi frequencies of the two halves of the A-robust pulse, the carrier Rabi frequencies for the two solutions are 76.05 kHz for robust FM and 116.89 and 63.56 kHz for the two halves of the A-robust pulse.

Figure 2 shows an example of five-ion discrete robust and A-robust FM gates on ions 2 and 4 with a gate time of 200 μ s. To find two robust pulses that give positive solutions for Eq. (16), we pick the initial-guess pulses near the lowest and the second-lowest mode, respectively.

C. Simulated gate performance

To compare the performances of robust and A-robust gates, we simulate the gate performance under different modefrequency drifts both for the ideal case and for the case based on our system performance [46] using the QUTIP masterequation solver [12]. To interpret a uniform mode-frequency drift, we add detuning offsets on the pulse frequencies, since as is shown in Eq. (2) they are mathematically equivalent. We simulate the two-qubit state populations starting from both ions at |0\) state after applying one MS gate with various detuning offsets (detuning scan) and the corresponding fidelity. The simulation results shown here are of the two-ion case, and the results of the five-ion case are shown in Appendix A; the five-ion case has behavior similar to that of the twoion case. For a two-ion chain, our measured heating rate is 10 quanta/s and < 1 quanta/s on radial COM and tilt modes, respectively, the motional coherence time is 3 ms, and the carrier coherence time is 330 ms. We use these parameters for simulating gate performance and refer to these errors as stochastic noise since they arise from random fluctuations in the system. We emphasize that low heating rate on both modes is beneficial to A-robust gates, as it strongly couples to each mode for half of the gate time.

Assuming perfect Rabi-frequency calibration, Fig. 3 shows the two-qubit population of the detuning scan and the fidelity of the robust and A-robust FM gate pulses in Fig. 1 with various detuning offsets. Here the fidelity is defined as the Bell-state fidelity, including errors from both residual dis-

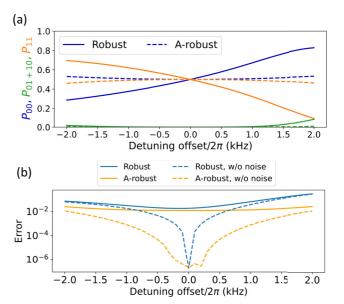


FIG. 3. Simulated detuning scan without stochastic noise (a) and gate error with and without stochastic noise (b) for the robust and A-robust pulses in Fig. 1. (a) The A-robust gate inherits the residual-displacement robustness, exhibiting flat odd-parity populations (P_{01+10}) around the 2-kHz detuning range. The even-parity populations (P_{00} and P_{11}) for A-robust has no first-order response on detuning, and thus both are closer to the ideal value 0.5 in the presence of detuning offsets. (b) Without stochastic noise, in the presence of detuning offsets, the error of the A-robust gate is orders of magnitude smaller than that of the robust gate. Note that the small gate errors at zero detuning offset are caused by imperfection of the numerically optimized solutions. With stochastic noise, the A-robust gate still outperforms the robust gate. In a system with less stochastic noise where a gate error of less than 10^{-2} can be reached, the advantage of the A-robust gate becomes more significant (see Appendix C).

placement and the rotation angle. The A-robust gates inherit the residual-displacement robustness from robust gates, while having the first-order response of total rotation angle to detuning offset removed. Due to the robustness of the rotation angle, within 2-kHz static detuning offset, the A-robust gate shows better tolerance to detuning offsets than the robust gate.

We further investigate the filter function (FF) of A-robust pulses for both residual displacement and the rotation angle. Details about the FF formalism and how it applies to gate robustness are discussed in Refs. [25,27,29,47]. Assuming the mode frequencies experience a uniform time-varying fluctuation of $\omega_k \rightarrow \omega_k + \delta(t)$, the gate errors in Eq. (6) are given by

$$\mathcal{E}_{\nu} = \int_{-\infty}^{\infty} df \frac{S_{\delta}(f)}{f^2} F_{\nu}(f), \quad \nu = \alpha, \Theta,$$
 (17)

where $S_{\delta}(f)$ is the power spectral density of $\delta(t)$ and

$$F_{\alpha}(f) = \sum_{k} \left[\left(b_{j_{1}}^{k} \right)^{2} + \left(b_{j_{2}}^{k} \right)^{2} \right] \left| \frac{\eta_{k}^{2}}{2} \int_{0}^{\tau} dt \Omega(t) e^{i[2\pi f t - \theta_{k}(t)]} \right|^{2},$$
(18)

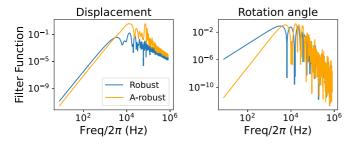


FIG. 4. The FFs of the pulses in Fig. 1 for residual displacement and the rotation angle. Robust and A-robust pulses have similar FFs for residual displacement, and A-robust pulses have have lower response of the rotation angle to noise with frequency below 10³ Hz.

$$F_{\Theta}(f) = \left| \int_{0}^{\tau} dt \int_{0}^{t} dt' (e^{2\pi i f t} - e^{2\pi i f t'}) \Omega(t) \Omega(t') \right| \times \sum_{k} \frac{\eta_{k}^{2}}{2} b_{j_{1}}^{k} b_{j_{2}}^{k} \cos[\theta_{k}(t) - \theta_{k}(t')] \right|^{2}$$
(19)

are the FFs for residual displacement and the rotation angle [25]. Figure 4 compares the displacement and rotation-angle FFs of the robust and A-robust pulses in Fig. 1. The two displacement FFs have similar behaviors, indicating the A-robust gate maintains the robustness against the displacement error as in the robust-FM gate. The rotation-angle FFs demonstrate the improved rotation-angle robustness against low-frequency noise of the A-robust gate. Below 10⁴ Hz, the rotation-angle FF of the A-robust gate shows a steeper slope, indicating removal of the first-order response of the rotation angle to static mode-frequency offsets [25].

IV. EXPERIMENTS

We experimentally measure the gate performance of robust and A-robust gates for the two-ion case. The experiment is conducted in a compact cryogenic trapped-ion system [46]. A two-ion ¹⁷¹Yb⁺ chain with a separation of about 5 µm is confined in a microfabricated linear radio-frequency Paul trap [48] with radial motional modes $\omega \sim (2\pi)2.0$ MHz. The qubit levels are encoded in the hyperfine ground states $|\downarrow\rangle \equiv {}^2S_{1/2}|F=0, m_F=0\rangle$ and $|\uparrow\rangle \equiv {}^2S_{1/2}|F=1, m_F=0\rangle$ 0) with a frequency splitting of $(2\pi)12.642821$ GHz [5]. The qubit rotations and ion-motion coupling transitions are driven by stimulated Raman transitions using two counterpropagating mode-locked 355-nm picosecond-pulsed laser beams. One global beam is shined on both ions, and two individual addressing beams are tightly focused onto each ion. The amplitude, frequency, and phase of Raman beams are controlled by a Xilinx Zync UltraScale+ Radio Frequency System-on-Chip (RFSoC) board using firmware designed by Sandia National Laboratories [49].

The robust-FM pulses are determined by a numerical optimizer which minimizes the residual displacement while guaranteeing its robustness to detuning offsets. Given the gate time, motional-mode frequencies, and constraints on the target Rabi frequency as input parameters, we let the optimizer

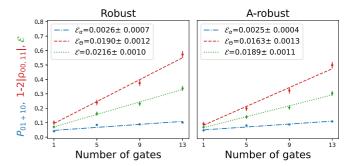


FIG. 5. Gate-error measurement of the robust and A-robust gates by applying repeated gate sequences. The blue (dash-dotted), red (dashed), and green (dotted) lines and dots are the odd-parity population of the $|01\rangle$ and $|10\rangle$ states, the parity contrast $1-2|\rho_{00,11}|$, and the measured gate error ${\cal E}.$ Both gates have similar odd-parity populations, and the parity contrast of the A-robust gate outperforms that of the robust gate.

search for a $XX(\pi/8)$ solution with half of the gate time. Then we either repeat the solution pulse twice to generate a robust $XX(\pi/4)$ solution or generate an A-robust $XX(\pi/4)$ solution using the construction method described in Sec. III A, such that the improvement of A-robust is not affected by other parameters such as different Rabi frequencies. The Bell-state fidelity is extracted by measuring the odd-parity population (P_{01+10}) and the parity contrast $(1-2|\rho_{00,11}|)$ [50], which reflect the displacement error and over-rotation error, respectively. In Appendix B we show the measured Bell-state fidelity of a FM $XX(\pi/4)$ solution, which is lower than that of either the repeated $XX(\pi/8)$ robust gate or the A-robust gate.

We compare the performance of the robust and A-robust FM MS-gate pulses with a fixed gate time of 270 µs by measuring the MS-gate fidelity and checking the gate performance under detuning offsets. The Bell-state fidelity is measured using the method in Ref. [12]: We initialize the qubit to the $|00\rangle$ state, and then we apply a sequence of 1, 5, 9, and 13 robust or A-robust FM gates and measure the final state fidelity. Finally we extract the gate fidelity from a linear fit of the final state fidelity versus the gate number. The measured MS-gate fidelity is 97.84(10)% for the robust gate and 98.11(11)% for the A-robust gate, as is shown in Fig. 5. Notice that both gates have similar $\mathcal{E}_{\alpha} \approx 0.25\%$, but the A-robust gate has better parity contrast, which leads to 0.27% overall fidelity improvement, indicating a more robust rotation angle under system noise. We expect a more significant improvement in systems where the mode-frequency drift is dominated by slow coherent noise instead of stochastic noise, which we believe is mostly limiting our current gate fidelity.

We further investigate the gate performance under mode-frequency drifts by introducing detuning offsets to the pulses and measuring the fidelity of the robust or A-robust gate. Figure 6 shows the detuning-scan results and Bell-state fidelity of five concatenated robust and A-robust gates under detuning offsets from -1 to 1 kHz. Both robust and A-robust gates have P_{01+10} close to zero and are robust against detuning offsets. Also, the A-robust gate's even-parity populations are

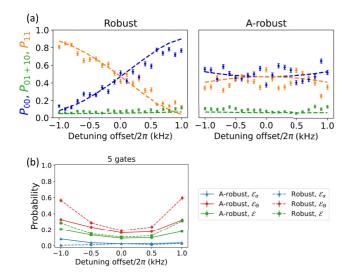


FIG. 6. (a) Experimental data (points) and simulation (dashed lines) of P_{01+10} , P_{00} , and P_{11} after applying five concatenated robust or A-robust gates, with detuning offsets ranging from -1 to 1 kHz. The P_{00} and P_{11} curves of the robust gate have a linear dependency on detuning offsets, while for the A-robust gate the first-order response is removed. (b) Measured odd-parity error \mathcal{E}_{α} , rotation angle error \mathcal{E}_{Θ} and gate error \mathcal{E} of five concatenated robust (dashed lines) and A-robust (solid lines) gates with detuning offsets. Overall the A-robust gate has better fidelity in the presence of detuning offsets.

more robust against detuning offsets, which implies a robust rotation angle.

V. DISCUSSIONS AND OUTLOOK

The idea of A-robust strategy can be incorporated with various other optimization schemes, and the optimization process can be adjusted based on realistic situations. A few possible future directions are listed here.

A. Combining A-robust with other optimization schemes

An A-robust gate inherits robustness of the residual displacement from robust gates, but what it can inherit is not limited to this: any pulse optimized for a certain feature can be concatenated to form an A-robust pulse with the same feature.

Here we take the filter-function robust (FF-robust) optimization protocol as an example [25]. Apart from suppressing low-frequency noise, the FF-robust optimization scheme searches for a pulse that is resilient to noise with a certain frequency. By concatenating two FF-robust pulses we can generate an A-robust gate ("AF-robust"), which maintains both residual-displacement and rotation-angle robustness in a low-frequency domain and a certain high-frequency range for displacement as designed. Figure 7 shows an example of two-ion FF-robust and AF-robust pulses and their filter functions that are designed to suppress noise of 5 kHz. In Appendix C we show the fidelity of the robust, A-robust, FF-robust, and AF-robust gates with different detuning offsets and noise parameters. We see that the AF-robust gate gives overall the best performance against detuning offsets and stochastic noise.

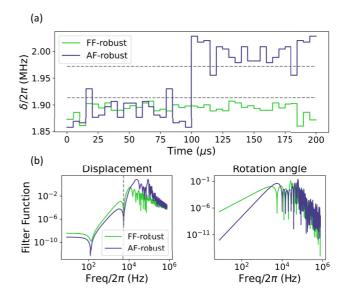


FIG. 7. (a) An example of 200- μ s pulses for two-ion discrete FF-robust and AF-robust FM $XX(\pi/4)$ pulses. The carrier Rabi frequencies for the FF- and AF-robust pulses are 73.65 and 100.36 kHz, respectively. (b) The FFs of the pulses in panel (a). The pulses are optimized such that the displacement FF is suppressed near 5 kHz (dashed line).

B. Nonuniform drifts on motional modes

If axial modes instead of radial modes are used for applying gates, or the mode-frequency instability is dominated by fluctuating dc voltages, the uniform-drift assumption fails. Therefore, in general, we aim to satisfy the angle-robustness condition in Eq. (13) with different but fixed values of r_k for each mode k. This can be taken into account when solving the factors β and $\tilde{\beta}$ in Eq. (16) by changing it into the form

$$\beta^{2}\Theta + \tilde{\beta}^{2}\tilde{\Theta} = \pi/4,$$

$$\beta^{2}\left(\sum_{k} \frac{\partial \Theta}{\partial \omega_{k}} r_{k}\right) + \tilde{\beta}^{2}\left(\sum_{k} \frac{\partial \tilde{\Theta}}{\partial \omega_{k}} r_{k}\right) = 0.$$
(20)

Thus the A-robust optimization scheme holds for nonuniform drift, providing that the A-robustness condition holds (comparatively small noise) and that the proportionalities of mode-frequency drifts are known.

C. Arbitrary-order suppression of rotation-angle error to detuning offsets

The A-robust concatenation protocol can be extended to suppressing the response of the rotation-angle error to detuning offsets up to arbitrary order. To realize an nth order suppression, we require n+1 different robust solutions (Ω_i, δ_i) for $i=1, \ldots, n+1$, each with total rotation angle Θ_i and a gradient over mode-frequency drift up to nth order, i.e., $\sum_{k_1, \ldots, k_j} \partial^j \Theta_i / (\partial \omega_{k_1} \cdots \partial \omega_{k_j})$, where $j=1, \ldots, n$. Then we apply AM to each robust solution by multiplying each Rabi frequency with a factor β_i which is determined by the

following set of linear equations:

$$\sum_{i=1}^{n+1} \beta_i^2 \Theta_i = \frac{\pi}{4},$$

$$\sum_{i=1}^{n+1} \beta_i^2 \left(\sum_{k_1, \dots, k_j} \frac{\partial^j \Theta_i}{(\partial \omega_{k_1} \cdots \partial \omega_{k_j})} \right) = 0, \quad j = 1, \dots, n.$$
 (21)

The concatenation of $(\beta_i \Omega_i, \delta_i)$, $i = 1, \ldots, n+1$, gives the total rotation angle equal to $\pi/4$ and the gradient over mode-frequency drift up to nth order equal to zero, leading to an nth order A-robust $XX(\pi/4)$ gate.

VI. CONCLUSION

In this paper, we show that by concatenating two robust MS-gate solutions and applying AM to their Rabi frequencies, we can demonstrate a gate scheme which has both residual displacement and rotation angle robust against static offsets or slow drifts in the mode frequencies. Experimentally we verify the rotation-angle robustness of the A-robust gate against detuning offsets in a compact cryogenic trapped-ion system and achieve a two-qubit gate fidelity of 98.11(11)%. We note that the A-robust strategy described in this work is applicable to any two-qubit gate scheme that involves a geometric phase, such as MS gates, light-shift gates, and laser-free gates [13–15,50–52].

When the gate time is fixed, the required Rabi frequency (or optical power) for A-robust gates is normally higher than that of robust gates. With a well-designed pulse optimizer, the required Rabi frequency can be constrained at the cost of solution imperfection.

Several other error sources that contribute to the rotationangle error include stochastic mode frequency drifting and errors on Rabi frequencies. One limitation of the A-robust strategy is that it cannot compensate the rotation-angle error due to optical power miscalibration or fluctuation, which leads to wrong Rabi frequencies and remains challenging using only MS-type interactions [25]. A recent work [53] provides a possible solution to power drifts by exciting second-order spin-motion coupling, thus implementing spindependent squeezing, at the cost of larger Rabi frequencies.

Note added. Recently, we became aware of Ref. [54], which also aims to eliminate the first-order response of the two-qubit rotation angle to uniform frequency drift by using AM and targeting the lowest two motional modes.

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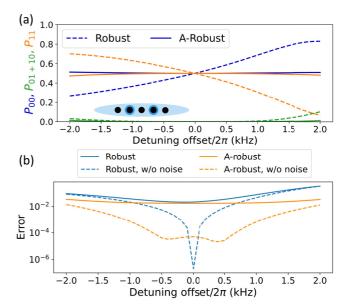


FIG. 8. Simulated results of robust and A-robust pulses in Fig. 2, which are for a five-ion chain. We simulate (a) detuning scans and (b) gate errors with different detuning offsets. Here we use a 3-ms motional coherence time and a 330-ms carrier coherence time. The motional heating rates used here are 50 quanta/s on the COM mode, 5 quanta/s on the second-highest mode, and 0 quanta/s on all other modes.

(spin-motion pulses); and ARO MURI Grant No. W911NF-18-1-0218 (distributed measurement protocol).

APPENDIX A: FIVE-ION SIMULATION RESULTS

In Sec. III C we show the simulation results of the robust and A-robust gates for the two-ion case. For multi-ion cases, the simulation results are similar to those of the two-ion case, and here we show the results of five-ion pulses in Fig. 2.

Figure 8 shows the simulated detuning scans and gate errors of the pulses on ions 2 and 4 of a five-ion chain, shown in Fig. 2, assuming perfect Rabi-frequency calibration. Similar to two-ion simulation results, the A-robust pulse has flat P_{00} and P_{11} with respect to detuning offsets, whereas the robust pulse holds a first-order dependence of P_{00} and P_{11} to detuning offsets. When looking at the fidelity, at zero detuning the robust gate has fidelity higher than that of the A-robust

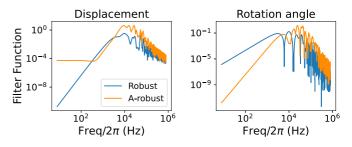


FIG. 9. The FFs for the five-ion robust and A-robust pulses in Fig. 2. The displacement FF of the A-robust pulse converges to a small but nonzero value at low frequencies, due to imperfection of the pulse solution. Similar to the two-ion case, the rotation-angle FF has a steeper slope when the frequency is below 10⁴ Hz.

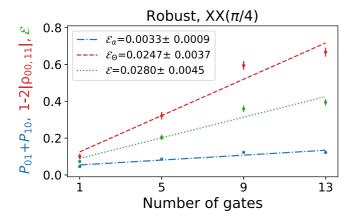


FIG. 10. Gate-error measurement of the robust $XX(\pi/4)$ pulse. Here the pulse is generated by directly searching for a robust $XX(\pi/4)$ solution, instead of repeating two robust $XX(\pi/8)$ pulses.

gate, mainly because each half segment of the A-robust pulse uses half the number of discrete steps compared to that of the robust pulse. When there exists a small detuning offset or stochastic noise, the five-ion A-robust gate outperforms the robust gate.

We further check the filter functions of the five-ion robust and A-robust pulses. Figure 9 shows the FFs of the pulses in Fig. 2. The rotation-angle FF shows behavior similar to that in Figs. 4 and 7: steeper slope at frequencies below 10⁴ Hz, indicating the first-order suppression of over-rotation error.

APPENDIX B: ROBUST $XX(\pi/4)$ -GATE BEHAVIOR

As a comparison with the A-robust gate and the repeated robust $XX(\pi/8)$ gate, we directly optimize for a robust $XX(\pi/4)$ solution with the same gate time of 270 μ s and then we measure the gate fidelity using the same approach as in Sec. IV. Figure 10 shows the measurement result, giving a gate fidelity of 97.20(48)%. The measured robust $XX(\pi/4)$ fidelity is lower than that of either the A-robust gate or the repeated robust $XX(\pi/8)$ gate.

APPENDIX C: COMPARING ROBUST, A-ROBUST, FF-ROBUST, AND AF-ROBUST PERFORMANCES

We numerically verify that when comparing the robust pulse, the A-robust pulse, the FF-robust pulse, and the concatenation of two FF-robust pulses using the A-robust strategy ("AF-robust"), the AF-robust pulse behaves overall the best against detuning offsets.

Figure 11 shows the simulated gate errors of all four pulses in Figs. 1 and 7 with various detuning offsets. Comparing with the robust and FF-robust pulses, the A-robust and AF-robust pulses show larger tolerance against detuning offsets. In particular, the AF-robust pulse further suppresses the error to $<10^{-4}$ without noise and $<10^{-2}$ with heating and motional dephasing noise, at the cost of requiring the highest Rabi frequency.

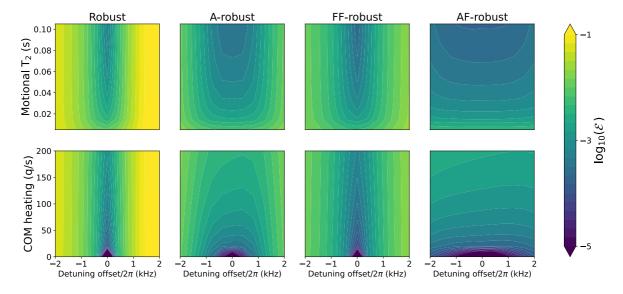


FIG. 11. The simulated gate errors of robust and A-robust pulses in Fig. 1 and FF-robust and AF-robust pulses in Fig. 7. The first row simulates the gate error with the motional coherence time T_2 varying from 5 to 100 ms. The second row simulates the gate error with the COM-mode heating rate varying from 0 to 200 q/s and the tilt-mode heating rate set as 1/10 of the COM-mode heating rate. The A-robust and AF-robust pulses have larger tolerance against detuning offsets, and the AF-robust pulse overall gives the best gate fidelity in the presence of detuning offsets and stochastic noise.

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